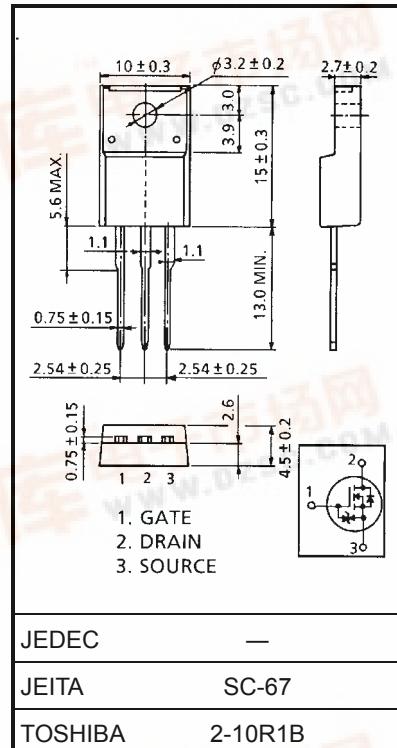


TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSV)

2SK3543

Switching Regulator and DC-DC Converter Applications
Motor Drive Applications

Unit: mm

JEDEC —
JEITA SC-67
TOSHIBA 2-10R1B

Weight: 1.9 g (typ.)

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-source voltage		V _{DSS}	450	V
Drain-gate voltage (R _{GS} = 20 kΩ)		V _{DGR}	450	V
Gate-source voltage		V _{GSS}	±30	V
Drain current	DC (Note 1)	I _D	2	A
	Pulse (Note 1)	I _{DP}	5	
Drain power dissipation (T _c = 25°C)		P _D	30	W
Single pulse avalanche energy (Note 2)		E _{AS}	103	mJ
Avalanche current		I _{AR}	2	A
Repetitive avalanche energy (Note 3)		E _{AR}	3	mJ
Channel temperature		T _{ch}	150	°C
Storage temperature range		T _{stg}	-55 to 150	°C

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th} (ch-c)	4.17	°C/W
Thermal resistance, channel to ambient	R _{th} (ch-a)	62.5	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 42.8 mH, R_G = 25 Ω, I_{AR} = 2 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

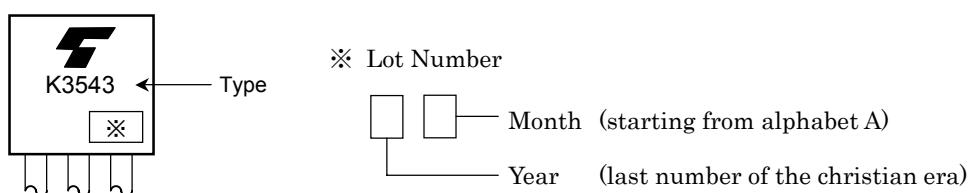
Electrical Characteristics ($T_a = 25^\circ\text{C}$)

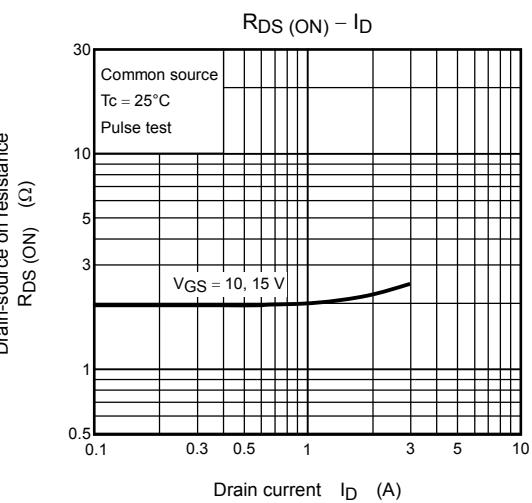
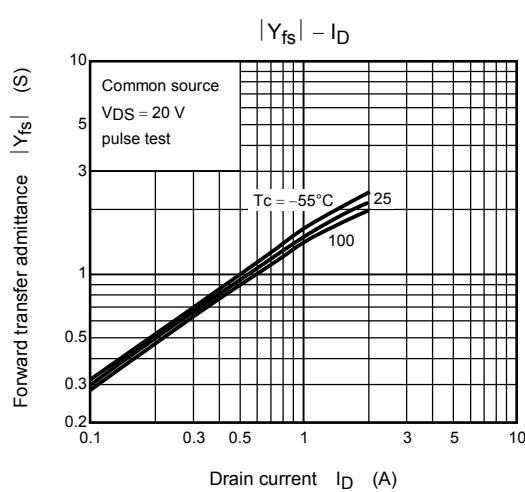
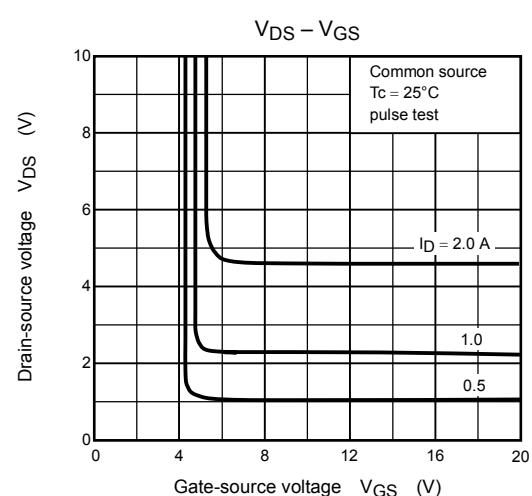
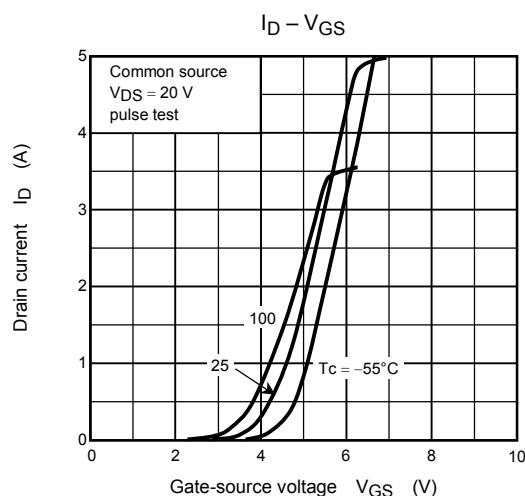
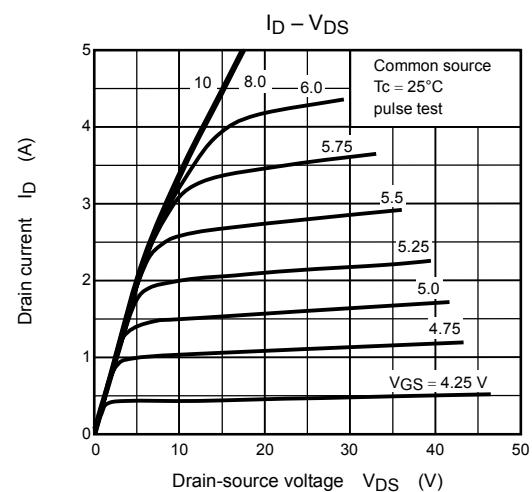
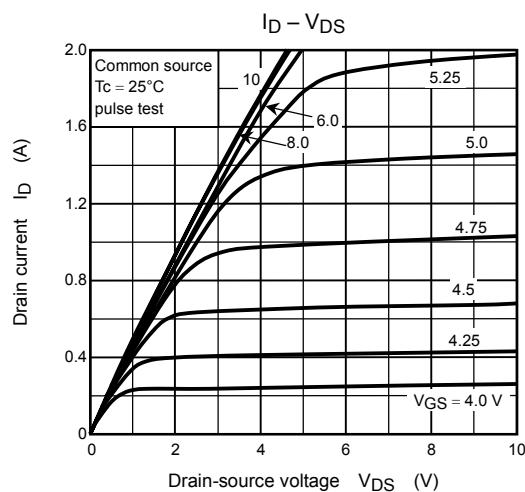
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit	
Gate leakage current	I_{GSS}	$V_{GS} = \pm 25\text{ V}$, $V_{DS} = 0\text{ V}$	—	—	± 10	μA	
Drain-source breakdown voltage	$V_{(\text{BR})\text{GSS}}$	$I_G = \pm 10\text{ }\mu\text{A}$, $V_{DS} = 0\text{ V}$	± 30	—	—	V	
Drain cut-OFF current	I_{DSS}	$V_{DS} = 450\text{ V}$, $V_{GS} = 0\text{ V}$	—	—	100	μA	
Drain-source breakdown voltage	$V_{(\text{BR})\text{DSS}}$	$I_D = 10\text{ mA}$, $V_{GS} = 0\text{ V}$	450	—	—	V	
Gate threshold voltage	V_{th}	$V_{DS} = 10\text{ V}$, $I_D = 1\text{ mA}$	2.0	—	4.0	V	
Drain-source ON resistance	$R_{DS(\text{ON})}$	$V_{GS} = 10\text{ V}$, $I_D = 1\text{ A}$	—	1.9	2.45	Ω	
Forward transfer admittance	$ Y_{fs} $	$V_{DS} = 10\text{ V}$, $I_D = 1\text{ A}$	0.6	1.3	—	S	
Input capacitance	C_{iss}	$V_{DS} = 10\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$	—	380	—	pF	
Reverse transfer capacitance	C_{rss}		—	40	—		
Output capacitance	C_{oss}		—	120	—		
Switching time	Rise time	t_r	 V_{GS} 10 V 0 V $I_D = 1\text{ A}$ V_{OUT} C_i 50 $R_L = 200\text{ }\Omega$ $V_{DD} \approx 200\text{ V}$ Duty $\leq 1\%$, $t_w = 10\text{ }\mu\text{s}$	—	15	—	ns
	Turn-ON time	t_{on}		—	25	—	
	Fall time	t_f		—	20	—	
	Turn-OFF time	t_{off}		—	80	—	
Total gate charge (gate-source plus gate-drain)	Q_g	$V_{DD} \approx 360\text{ V}$, $V_{GS} = 10\text{ V}$, $I_D = 2\text{ A}$	—	9	—	nC	
Gate-source charge	Q_{gs}		—	5	—		
Gate-drain ("miller") charge	Q_{gd}		—	4	—		

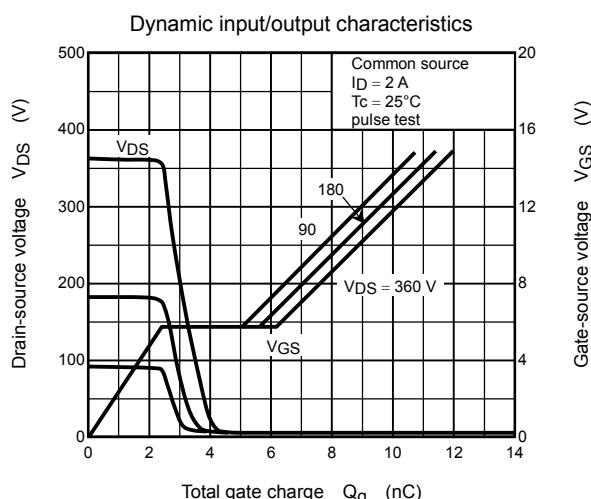
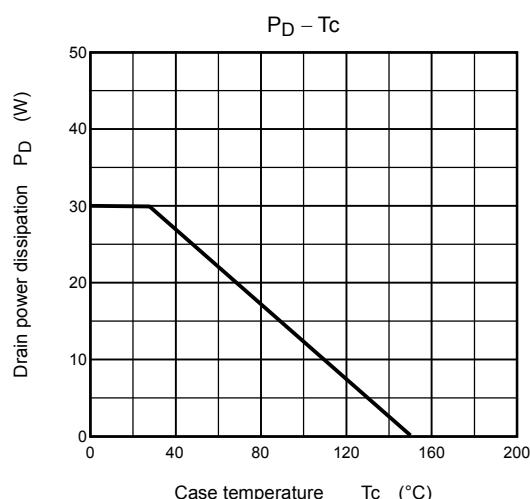
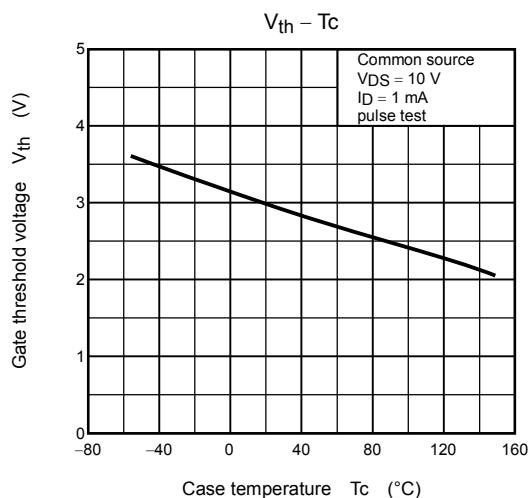
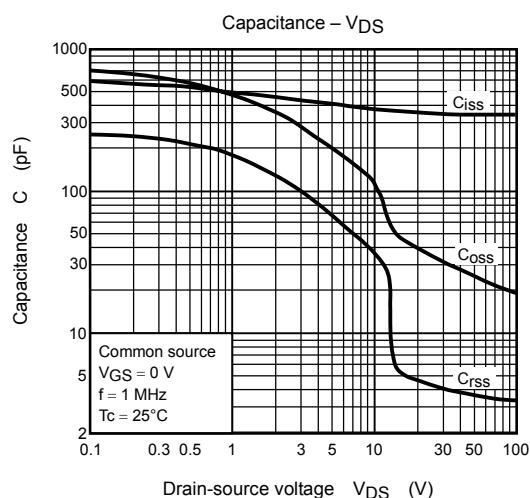
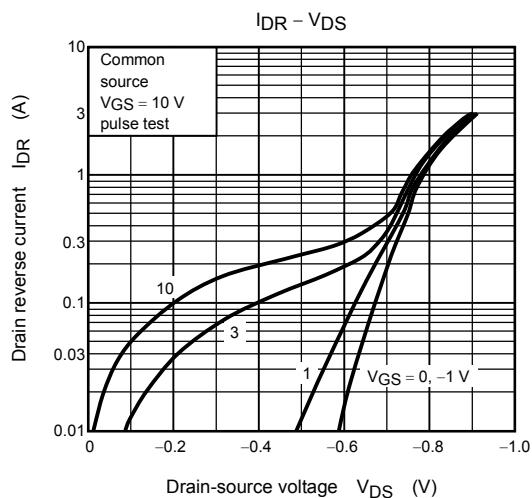
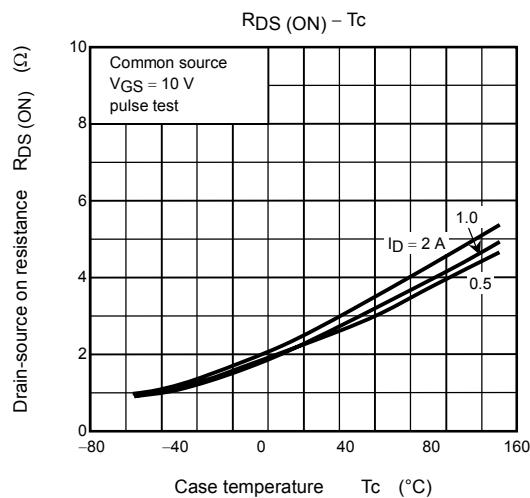
Source-Drain Ratings and Characteristics ($T_a = 25^\circ\text{C}$)

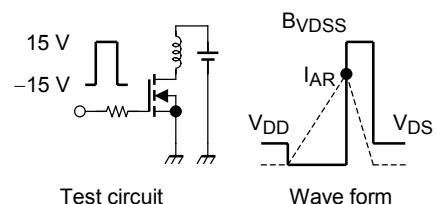
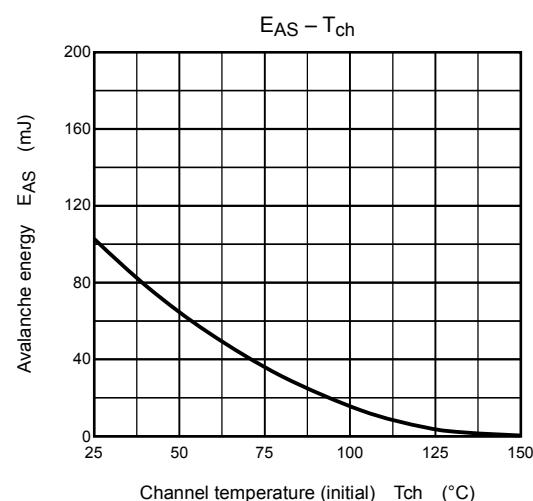
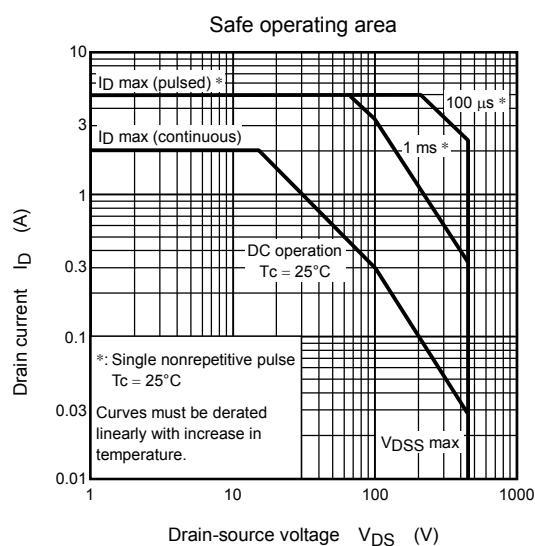
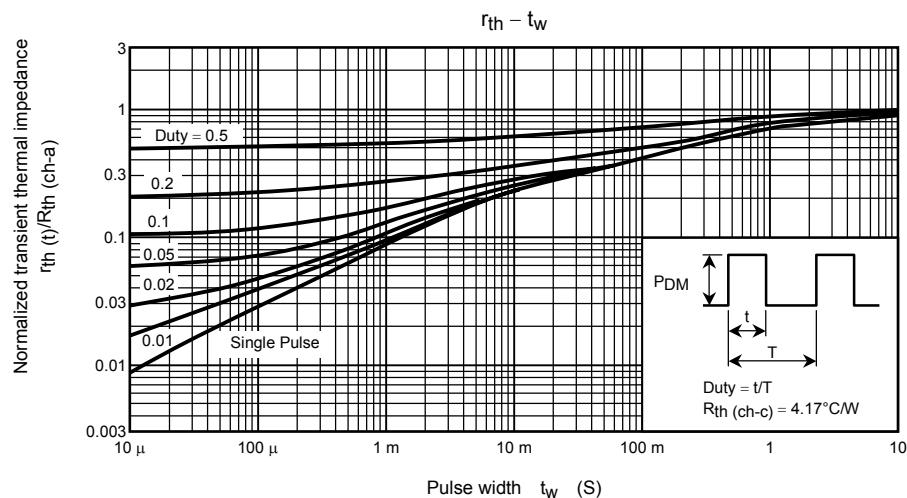
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current (Note 1)	I_{DR}	—	—	—	2	A
Pulse drain reverse current (Note 1)	I_{DRP}	—	—	—	5	A
Forward voltage (diode)	V_{DSF}	$I_{DR} = 2\text{ A}$, $V_{GS} = 0\text{ V}$	—	—	-1.5	V
Reverse recovery time	t_{rr}	$I_{DR} = 2\text{ A}$, $V_{GS} = 0\text{ V}$, $dI_{DR}/dt = 100\text{ A}/\mu\text{s}$	—	1000	—	ns
Reverse recovery charge	Q_{rr}		—	3.5	—	μC

Marking









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